

<b>Search Notes</b> 	<b>Application/Control No.</b>  10/511,972	<b>Applicant(s)/Patent under Reexamination</b>  HOELEN ET AL.
	<b>Examiner</b>  David J. Makiya	<b>Art Unit</b>  2875

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
362	610,615	9/21/2006	DJM
	616,619		
	623-626		
Interference search in EAST		9/21/2006	DJM